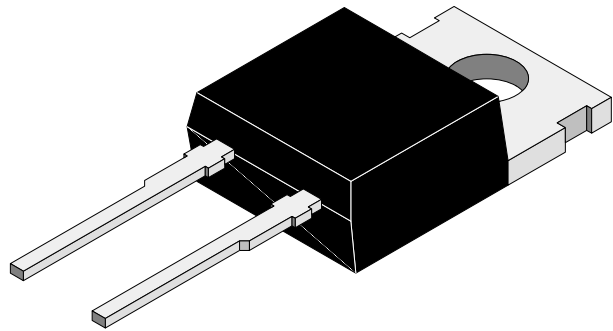


Fast Recovery Silicon Power Rectifier

Features

- Multiple diffusion
- Mesa glass passivated
- Low switch on power losses
- Good soft recovery behaviour
- Fast forward recovery time
- Low reverse current
- Very low turn on transient peak voltage
- Very good reverse current stability at high temperature
- Low thermal resistance



94 9537

Applications

Fast rectifiers in S.M.P.S.

Freewheeling diodes and snubber diodes in motor control circuits

Absolute Maximum Ratings

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Value	Unit
Reverse voltage, repetitive peak reverse voltage			$V_R = V_{RRM}$	1000	V
Peak forward surge current	$t_p = 10\text{ms}$		I_{FSM}	50	A
Repetitive peak forward current			I_{FRM}	16	A
Average forward current			I_{FAV}	8	A
Junction temperature			T_j	150	$^\circ\text{C}$
Storage temperature range			T_{stg}	-40...+150	$^\circ\text{C}$

Maximum Thermal Resistance

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Symbol	Value	Unit
Junction case		R_{thJC}	2.0	K/W
Junction ambient		R_{thJA}	85	K/W

Characteristics

$T_j = 25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Forward voltage	$I_F=8\text{A}$		V_F			1.9	V
	$I_F=8\text{A}, T_j=100^\circ\text{C}$		V_F			1.8	V
Reverse current	$V_R=V_{RRM}$		I_R			35	μA
	$V_R=V_{RRM}, T_j=100^\circ\text{C}$		I_R			2.5	mA
Forward recovery time	$I_F=8\text{A}, di_F/dt \leq 50\text{A}/\mu\text{s}$		t_{fr}		350		ns
Turn on transient peak voltage			V_{FP}			4.5	V
Reverse recovery characteristics, see Fig. 3	$I_F=8\text{A}, di_F/dt \leq -32\text{A}/\mu\text{s}, V_{Batt}=200\text{V}, T_j=100^\circ\text{C}$		I_{RM}			5.5	A
			t_{IRM}		80	200	ns
Reverse recovery time	$I_F=8\text{A}, di_F/dt \leq -32\text{A}/\mu\text{s}, V_{Batt}=200\text{V}, T_j=100^\circ\text{C}, i_R=0.25 \times I_{RM}$		t_{rr}		120		ns
Reverse recovery time	$I_F=0.5\text{A}, I_R=1\text{A}, i_R=0.25\text{A}$		t_{rr}			65	ns

Typical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

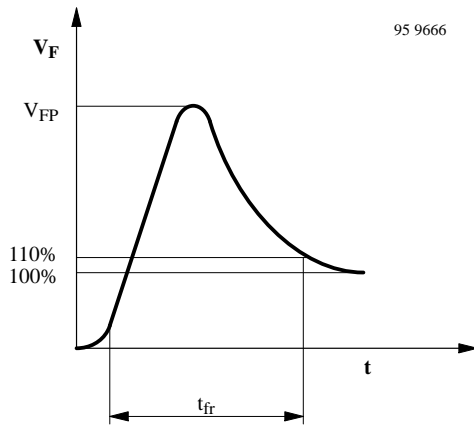


Figure 1 : Turn on transient peak voltage

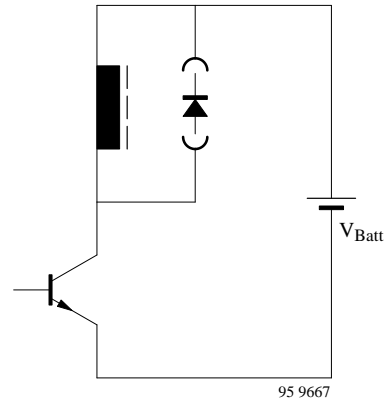


Figure 2 : Test circuit

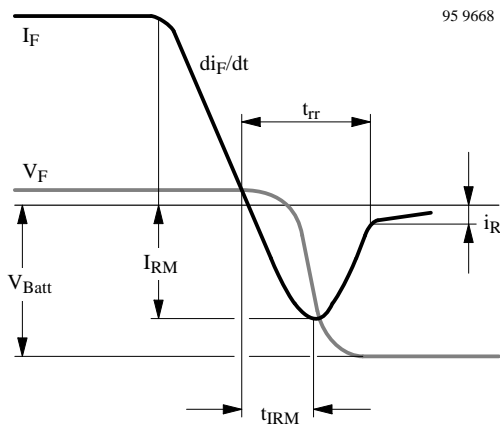


Figure 3 : Turn off switching characteristic

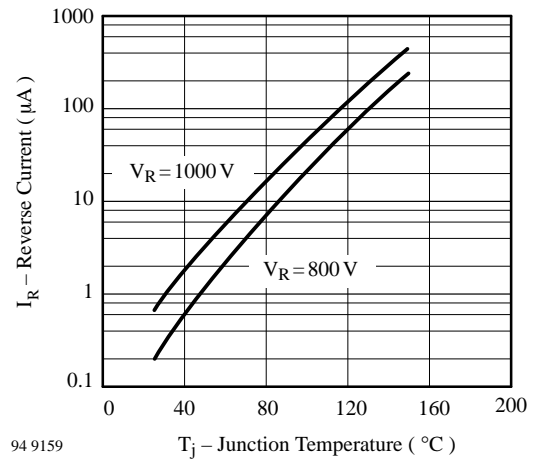


Figure 4 : Reverse Current vs. Junction Temperature

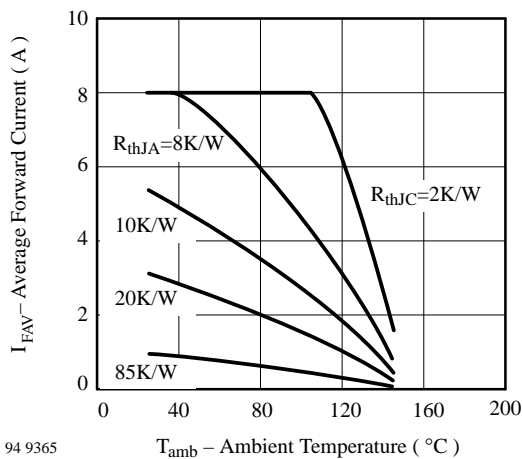


Figure 5 : Average Forward Current vs. Ambient Temperature

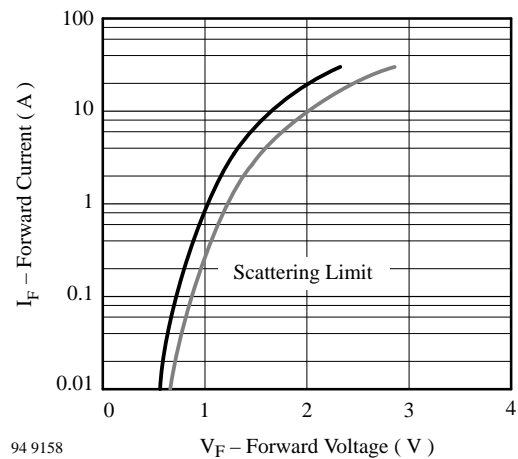


Figure 6 : Forward Current vs. Forward Voltage

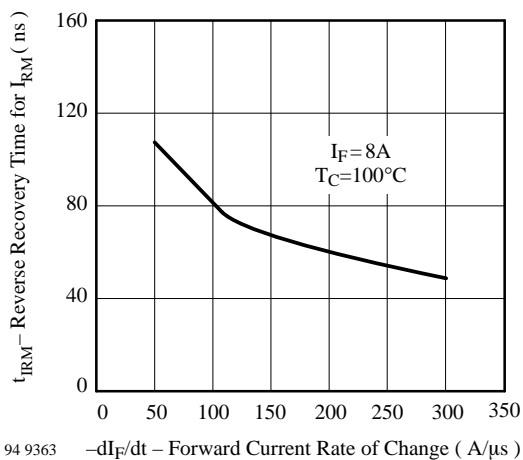


Figure 7 : Reverse Recovery Time for IRM vs. Forward Current Rate of Change

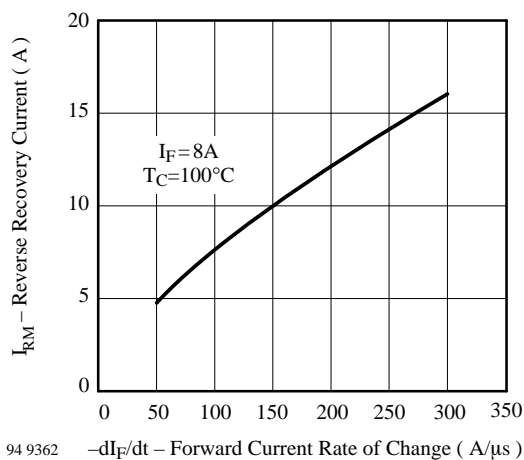


Figure 8 : Reverse Recovery Current vs. Forward Current Rate of Change

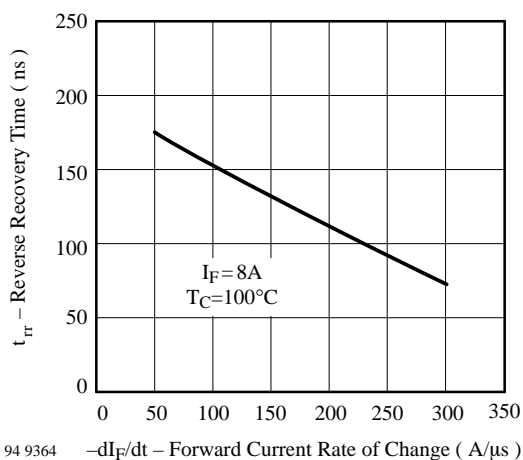


Figure 9 : Reverse Recovery Time vs. Forward Current Rate of Change

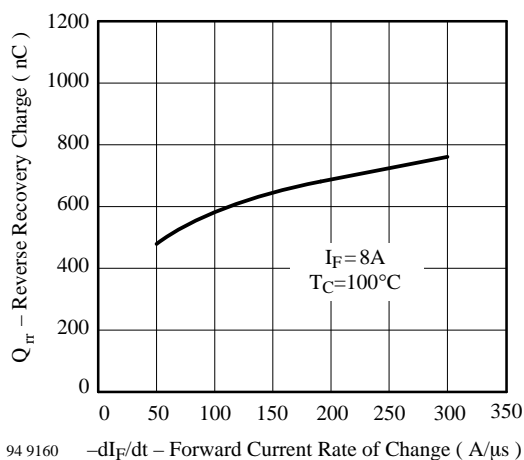
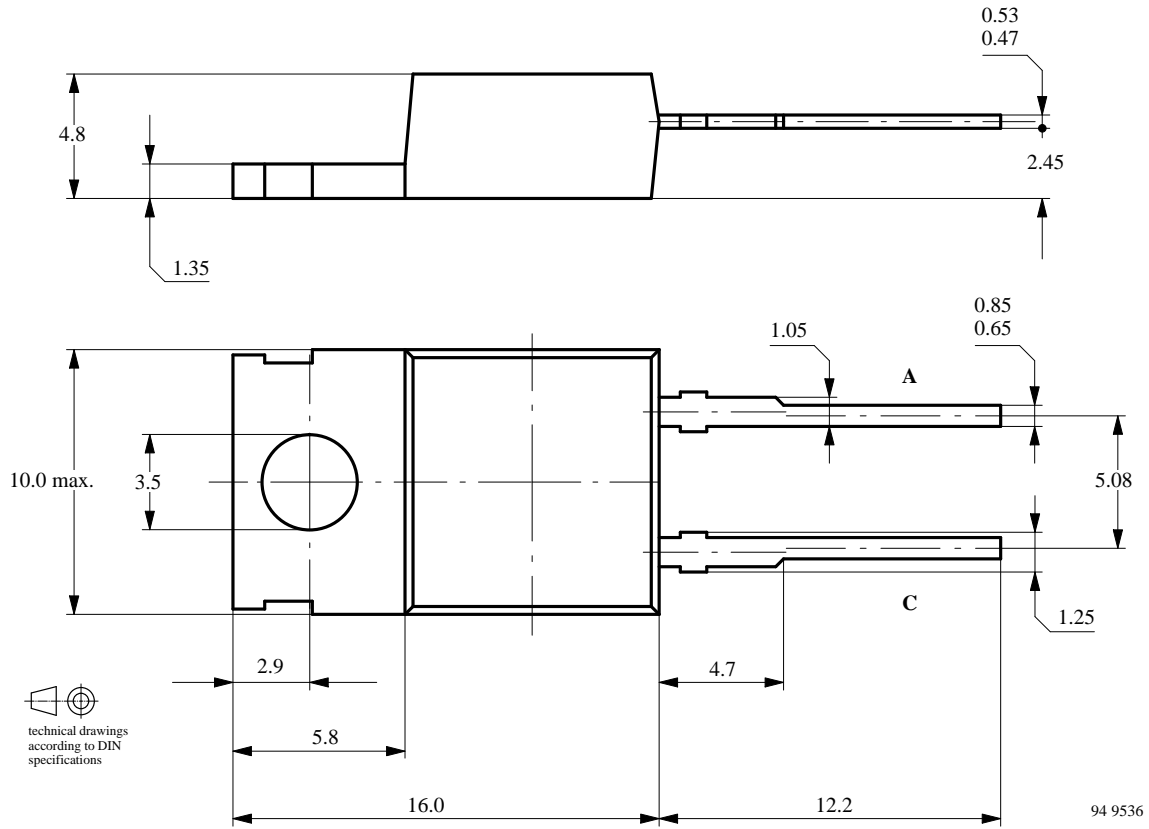


Figure 10 : Reverse Recovery Charge vs. Forward Current Rate of Change

Dimensions in mm



Cathode connected with metallic surface , Plastic Case DO 220 , Weight max.: 2.5 g

OZONE DEPLETING SUBSTANCES POLICY STATEMENT

It is the policy of **TEMIC TELEFUNKEN microelectronic GmbH** to

1. Meet all present and future national and international statutory requirements and
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

Of particular concern is the control or elimination of releases into the atmosphere of those substances which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) will soon severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of any ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA and
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with and do not contain ozone depleting substances.

We reserve the right to make changes to improve technical design without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use TEMIC products for any unintended or unauthorized application, the buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

TEMIC TELEFUNKEN microelectronic GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany
Telephone: 49 (0)7131 67 2831, Fax Number: 49 (0)7131 67 2423